

<b>Notice of References Cited</b>	Application/Control No. 10/667,083	Applicant(s)/Patent Under Reexamination ALLEN ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,405,348	06-2002	Fallah-Tehrani et al.	716/4
	B	US-6,721,930	04-2004	Sasaki et al.	716/6
	C	US-6,772,403	08-2004	Sasaki, Yasuhiko	716/6
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Chen et al., "On Convergence of Switching Windows Computation in Presence of Crosstalk Noise", 7 April 2002, ISPD'02, Pages 84-89
	V	Chen et al., "Switching Windows Computation for Static Timing Analysis in Presence of Crosstalk Noise", Computer Aided Design, 2000. ICCAD-2000. IEEE/ACM International Conference on □□5-9 Nov. 2000 Page(s):331 - 337
	W	Chen et al., "Towards true crosstalk noise analysis", Computer-Aided Design, 1999. Digest of Technical Papers. 1999 IEEE/ACM International
	X	Levi et al., "ClariNet: a noise analysis tool for deep submicron design", Design Automation Conference, 2000. Proceedings 2000. 37th, June 5-9, 2000 Page(s):233 - 238 □□

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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	A	US-			
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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Glebov et al., "False-noise analysis using logic implications", Computer Aided Design, 2001. ICCAD 2001. IEEE/ACM International Conference on, 4-8 Nov. 2001 Page(s):515 - 521
	V	
	W	
	X	

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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.